



Client	Qingdao MicroSense Intelligent Technology Co.,Ltd.	
Address	Room 803,Floor 8, Building F, Innovation Park II, No. 1, Keyuan Wei 1st Road, Laoshan District, Qingdao, Shandong, China	
Tester	Weifang Goertek Microelectronics Co.,Ltd Testing Lab	
Address	No.268, Dongfang Road, Hi-Tech Industry Development Zone, Weifang, Shandong, China	
Test Site	Reliability laboratory, first floor, complex building	

Sample Informations

Sample	3D TOF CAMERA
Model	NYX650
Status of Sample	In good condition
Date of Receival	2024.06.13
Test Date	2024.06.13~2024.06.26
Test Item	Damp heat, steady state Test, Damp heat, cyclic, Cold, Change of temperature, ESD, Free fall *, Shock
Test Result	See the body of the report
Remark	The test basis and test items marked "*" are not within the scope of CNAS accreditation of our laboratory.



I promise to be responsible for the accuracy and effectiveness of the reported data.

The following is the body of the report:

Test Item Number	240606LR005-00-00	
1.Message of the Sample		
Sample Quantity	3	
Sample No.	1#~3#	

2.Test Method

GB/T 2423.3-2016 Environmental testing-Part 2:Testing method-Test Cab:Damp heat, steady state

3.Test Requipment

Test Item	Damp heat, steady state Test
Test Condition	60°C 90%RH 120H,Sample work with voltage of 12V

4.Test Process

Test Equipment	M-YB-0600 Temperature&Humidity Chamber Model:EW0440S
Calibration Date	2023.08.27-2024.08.26
Environmental Conditions	Temperature:22.3°C,Humidity:46.8%RH,Atmospheric Pressure:100.1kPa
Test By	Pengfei Wang
Test Date	2024.06.16 20:46:00 - 2024.06.21 23:11:00

5.Test Result

There was no obvious abnormality in the appearance of the samples before and after the test, and the depth image could be displayed normally when the samples were powered on.

6.Test Photos

Damp heat, steady state Test



Obverse photo before test



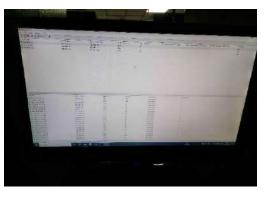
Sample placement photo

程序员				C. C	程序号:	17 ST	P 号 📶
STEP	小时	:	分钟	%°C	温度 ℃	温度 知出	开关
0	0	:	1.0	11	+25.0	50. 0	00000000
1	0	:	35.0	0	+60, 0	50.0	00000000
2	0	:	30.0	0	+60, 0	90, 0	0000000
3	120	:	0.0	0	+60.0	90, 0	00000000
4	0	:	30.0	0	+60.0	50, 0	00000000
5	0	:	35.0	0	+25. 0	50, 0	00000000
				周期	月 详细	<	> 【 结束
		-					

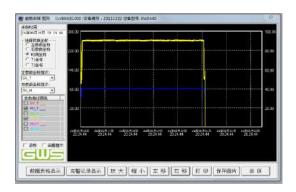
Test program setup



Reverse photo before test



Sample work monitoring photo



Trial curve



Obverse photo after test



Reverse photo after test

Test Item Number	240606LR005-01-00

1.Message of the Sample

Sample Quantity 3

Sample No. $4\#\sim 6\#$

2.Test Method

GB/T 2423.4-2008 Environmental testing for electric and eletronic products ——Part2:Test methods Test Db:Damp heat,cyclic(12 h+12h cycle)

3.Test Requipment

Test Item	Damp heat, cyclic Test	
Test Condition	$25^\circ\!\mathrm{C}$ 95%RH/9H~55 $^\circ\!\mathrm{C}$ 95%RH/9H, change time 3hours,3 cycles, Sample work with voltage of 12V	

4.Test Process

Test Equipment	M-YB-0600 Temperature&Humidity Chamber Model:EW0440S
Calibration Date	2023.08.27-2024.08.26
Environmental Conditions	Temperature:23.1 °C,Humidity:46.5%RH,Atmospheric Pressure:100.1kPa
Test By	Pengfei Wang
Test Date	2024.06.13 13:45:00 - 2024.06.16 13:48:00

5.Test Result

There was no obvious abnormality in the appearance of the samples before and after the test, and the depth image could be displayed normally when the samples were powered on.

6.Test Photos

Damp heat, cyclic Test



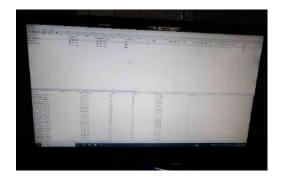
Obverse photo before test



Sample placement photo



Reverse photo before test



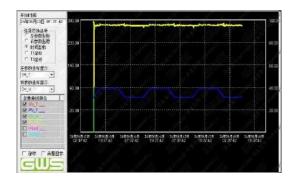
Sample work monitoring photo



Test program setup



Obverse photo after test



Trial curve



Reverse photo after test

Test Item Number	240606LR005-02-00
1.Message of the Sample	

Sampl	e Quantity	3

Sample No. $7\# \sim 9\#$

2.Test Method

GB/T 2423.3-2016 Environmental testing-Part 2:Testing method-Test Cab:Damp heat, steady state

3.Test Requipment

Test Item	Damp heat, steady state Test
Test Condition	70°C 90%RH,Storage 120H
4.Test Process	
Test Equipment	M-YB-0104 Temperature&Humidity Chamber Model:EW0440
Calibration Date	2023.08.26-2024.08.25
Environmental Conditions	Temperature:22.6°C,Humidity:51.9%RH,Atmospheric Pressure:99.7kPa
Test By	Jie Zhang
Test Date	2024.06.14 20:12:00 - 2024.06.19 22:40:00

5.Test Result

There was no obvious abnormality in the appearance of the samples before and after the test, and the depth image could be displayed normally when the samples were powered on.

6.Test Photos

Damp heat, steady state Test



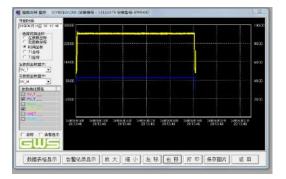
Obverse photo before test



Reverse photo before test



Sample placement photo



Trial curve



Obverse photo after test

STEP	小时	:	分钟	XC	温度℃	温度%RH	开关
0	0	:	1.0	11	+25.0	50.0	00000000
1		:	45.0	00	+70.0	50.0	0000000
2	0	:	30, 0	00	+70.0	90, 0	00000000
3	120	:	0.0	00	+70.0	90, 0	00000000
4	0	:	30.0	00	+70.0	50, 0	00000000
5	0	:	45.0	00	+25, 0	50, 0	00000000
		8					beideren in

Test program setup



Reverse photo after test

Test Item Number	240606LR005-03-00
1.Message of the Sample	
Sample Quantity	3
Sample No.	10#~12#

2.Test Method

GB/T 2423.1-2008 Environmental testing for electric and electronic products —Part2:Test methods—Tests A:Cold

3.Test Requipment

Test Item	Cold Test
Test Condition	-30°C, Storage 120H

4.Test Process

Test Equipment	M-YB-0093 Temperature Chamber Model:MC-711
Calibration Date	2024.04.27-2025.04.26
Environmental Conditions	Temperature:23.1 °C,Humidity:46.5%RH,Atmospheric Pressure:100.1kPa
Test By	Pengfei Wang
Test Date	2024.06.13 13:37:00 - 2024.06.18 15:55:00

5.Test Result

There was no obvious abnormality in the appearance of the samples before and after the test, and the depth image could be displayed normally when the samples were powered on.

6.Test Photos

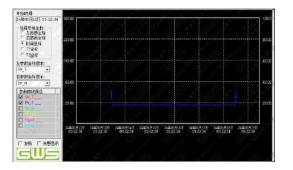
Cold Test



Obverse photo before test



Sample placement photo



Trial curve



Reverse photo before test



Test program setup



Obverse photo after test



Reverse photo after test

240606LR005-04-00
3
13#~15#

2.Test Method

GB/T 2423.22-2012 Environmental testing —Part2:Test methods —Test N:Change of temperature Test Na

3.Test Requipment

Test Item	Change of temperature Test
Test Condition	High Temp:85°C;Low Temp:-40°C;Each step duration for 30min;Transition : < 5 min;Cycle:45

4.Test Process

Test Equipment	M-YB-0012 Thermal Shock Test Chamber Model:TS130
Calibration Date	2024.04.27-2025.04.26

Environmental Conditions	Temperature:23.1°C,Humidity:46.5%RH,Atmospheric Pressure:100.1kPa
Test By	Jie Zhang
Test Date	2024.06.13 23:13:00 - 2024.06.15 20:13:00

5.Test Result

There was no obvious abnormality in the appearance of the samples before and after the test, and the depth image could be displayed normally when the samples were powered on.

6.Test Photos

Change of temperature Test



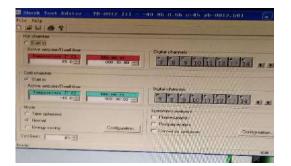
Obverse photo before test



Reverse photo before test



photo of test equipment



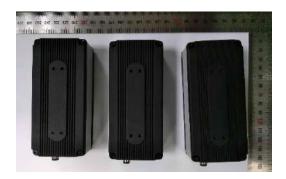
Test program setup



Obverse photo after test



Trial curve



Reverse photo after test

Test Item Number	240606LR005-05-00
1.Message of the Sample	
Sample Quantity	4

Sample No. 16#~19#

2.Test Method

GB/T 17626.2-2018 Electromagnetic compatibility—Testing and measurement techniques— Electrostatic discharge immunity test

3.Test Requipment

Test Item	Electrostatic discharge immunity Test
Test Condition	Contact discharge:discharge voltage: ±4kV,discharge counts:10,discharge position:outer shell,Sample ungrounded and work with voltage of 12V; Air discharge:discharge voltage: ±8kV,discharge counts:10,discharge position:shell gap,Sample ungrounded and work with voltage of 12V.
4.Test Process	
Test Equipment	M-DG-0457 Electrostatic discharge tester Model:ESS-B3011>-30R
Calibration Date	2023.08.10-2024.08.09
Environmental Conditions	Temperature:22°C,Humidity:50%RH,Atmospheric Pressure:100.1kPa
Test By	Pengfei Wang
Test Date	2024.06.13 11:00:00 - 2024.06.13 15:00:00

5.Test Result

There was no obvious abnormality in the appearance of the samples before and after the test, and the depth image could be displayed normally when the samples were powered on.

6.Test Photos

Electrostatic discharge immunity Test



Obverse photo before test



Reverse photo before test



Test layout



Contact discharge setting



Air discharge setting



Obverse photo after test



Test setup



Contact discharge process



Air discharge process



Reverse photo after test

Test Item Number	240606LR005-06-00
1.Message of the Sample	
Sample Quantity	3
Sample No.	20#~22#

2.Test Method

GB/T 2423.7-2018 Environmental testing—Part 2:Test methods—Test Ec:Rough handing shocks,primarily for equipment-type specimens

3.Test Requipment

Test Item	Free fall*
Test Condition	76cm,One corner, three edges and five sides(do not do the face with the plug)

4.Test Process

Test Equipment	M-YC-0033 Single drop frame Model:ZZCSY
Calibration Date	2023.10.10-2024.10.09
Environmental Conditions	Temperature:22.8°C,Humidity:46.5%RH,Atmospheric Pressure:100.5kPa
Test By	Jie Zhang
Test Date	2024.06.25 16:40:00 - 2024.06.25 17:40:00

5.Test Result

There was no obvious abnormality in the appearance of the samples before and after the test, and the depth image could be displayed normally when the samples were powered on.

6.Test Photos

Free fall Test



Obverse photo before test



Drop height



Drop process 1



Reverse photo before test



Drop surface



Drop process 2



Obverse photo after test



Reverse photo after test

Test Item Number	240606LR005-07-00			
1.Message of the Sample				
Sample Quantity	3			
Sample No.	23#~25#			

2.Test Method

GB/T 2423.5-2019 Environmental testing—Part 2:Test methods—Test Ea and guidance: Shock

3.Test Requipment

Test Item	Shock			
Test Condition	$6axis(\pm X,\pm Y,\pm Z)$, 5	50g, 11ms,	Half sine,	No Package 3 times

4.Test Process

Test Equipment	M-YC-0185 Electric vibration table Model:DC-600-6
Calibration Date	2023.09.20-2024.09.19

Environmental Conditions	Temperature:22.6°C,Humidity:51.3%RH,Atmospheric Pressure:99.5kPa
Test By	Qingpeng Xin
Test Date	2024.06.20 16:00:00 - 2024.06.20 17:00:00

5.Test Result

There was no obvious abnormality in the appearance of the samples before and after the test, and the depth image could be displayed normally when the samples were powered on.

6.Test Photos

Shock Test



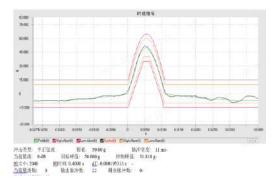
Obverse photo before test



Sample placement



Reverse photo before test



trial curve



Obverse photo after test



Reverse photo after test

******End of Report******

1. The test report without the approval of the signature and "Weifang Goertek Microelectronics Co., Ltd. Testing Lab" chapter is invalid;

2. The laboratory is not responsible for sampling, and this report is only responsible for the test results of the tested samples;

3. The Laboratory is not responsible for data or information provided by the customer that may affect the validity of the results;

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